

30V P-Channel MOSFETs

General Description

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

| | | |
|-------|---------------------|------|
| BVDSS | R _{DS(ON)} | ID |
| -30V | 4.8mΩ | -24A |

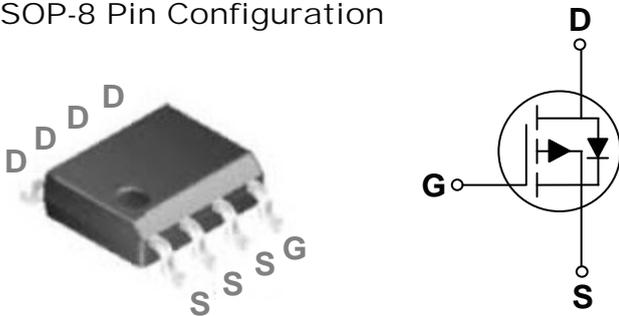
Features

- -30V,-24A, R_{DS(ON)} =4.8mΩ @V_{GS} = -10V
- Fast switching
- Green Device Available
- Suit for -4.5V Gate Drive Applications

Applications

- Motor Driver Applications
- POL Applications
- Load Switch
- LED Application

SOP-8 Pin Configuration



Absolute Maximum Ratings (T_c=25°C unless otherwise noted)

| Symbol | Parameter | Rating | Units |
|------------------|--|------------|-------|
| V _{DS} | Drain-Source Voltage | -30 | V |
| V _{GS} | Gate-Source Voltage | ± 20 | V |
| I _D | Drain Current – Continuous (T _C =25°C) | -24 | A |
| | Drain Current – Continuous (T _C =100°C) | - | A |
| I _{DM} | Drain Current – Pulsed ¹ | -96 | A |
| P _D | Power Dissipation (T _C =25°C) | 2.1 | W |
| | Power Dissipation – Derate above 25°C | 0.017 | W/°C |
| T _{STG} | Storage Temperature Range | -55 to 150 | °C |
| T _J | Operating Junction Temperature Range | -55 to 150 | °C |

Thermal Characteristics

| Symbol | Parameter | Typ. | Max. | Unit |
|------------------|--|------|------|------|
| R _{θJA} | Thermal Resistance Junction to Ambient | --- | 60 | °C/W |
| R _{θJC} | Thermal Resistance Junction to Case | --- | 24 | °C/W |

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Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Off Characteristics

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|------------------------------|------------------------------------|---|------|-------|-----------|---------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS}=0V, I_D=-250\mu A$ | -30 | --- | --- | V |
| $\Delta BV_{DSS}/\Delta T_J$ | BV_{DSS} Temperature Coefficient | Reference to 25°C , $I_D=-1\text{mA}$ | --- | -0.03 | --- | V/ $^\circ\text{C}$ |
| I_{DSS} | Drain-Source Leakage Current | $V_{DS}=-30V, V_{GS}=0V, T_J=25^\circ\text{C}$ | --- | --- | -1 | μA |
| | | $V_{DS}=-24V, V_{GS}=0V, T_J=125^\circ\text{C}$ | --- | --- | -10 | μA |
| I_{GSS} | Gate-Source Leakage Current | $V_{GS}=\pm 20V, V_{DS}=0V$ | --- | --- | ± 100 | nA |

On Characteristics

| | | | | | | |
|---------------------|--------------------------------------|--------------------------------|------|------|------|----------------------|
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance | $V_{GS}=-10V, I_D=-17.5A$ | --- | 3.8 | 4.8 | m Ω |
| | | $V_{GS}=-4.5V, I_D=-10A$ | --- | 5.8 | 7.8 | m Ω |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}=V_{DS}, I_D=-250\mu A$ | -1.2 | -1.6 | -2.2 | V |
| $\Delta V_{GS(th)}$ | $V_{GS(th)}$ Temperature Coefficient | | --- | 4 | --- | mV/ $^\circ\text{C}$ |
| gfs | Forward Transconductance | $V_{DS}=-10V, I_D=-5A$ | --- | 25 | --- | S |

Dynamic and switching Characteristics

| | | | | | | |
|--------------|------------------------------------|--|-----|------|------|----|
| Q_g | Total Gate Charge ^{2,3} | $V_{DS}=-15V, V_{GS}=-10V, I_D=-10A$ | --- | 108 | 150 | nC |
| Q_{gs} | Gate-Source Charge ^{2,3} | | --- | 15 | 25 | |
| Q_{gd} | Gate-Drain Charge ^{2,3} | | --- | 17.4 | 30 | |
| $T_{d(on)}$ | Turn-On Delay Time ^{2,3} | $V_{DD}=-15V, V_{GS}=-10V, R_G=6\Omega$ $I_D=-1A$ | --- | 28 | 56 | ns |
| T_r | Rise Time ^{2,3} | | --- | 16 | 32 | |
| $T_{d(off)}$ | Turn-Off Delay Time ^{2,3} | | --- | 178 | 340 | |
| T_f | Fall Time ^{2,3} | | --- | 72 | 140 | |
| C_{iss} | Input Capacitance | $V_{DS}=-25V, V_{GS}=0V, F=1\text{MHz}$ | --- | 6220 | 9000 | pF |
| C_{oss} | Output Capacitance | | --- | 782 | 1100 | |
| C_{rss} | Reverse Transfer Capacitance | | --- | 412 | 600 | |

Drain-Source Diode Characteristics and Maximum Ratings

| Symbol | Parameter | Conditions | Min. | Typ. | Max. | Unit |
|----------|---------------------------|--|------|------|------|------|
| I_S | Continuous Source Current | $V_G=V_D=0V$, Force Current | --- | --- | -24 | A |
| I_{SM} | Pulsed Source Current | | --- | --- | -48 | A |
| V_{SD} | Diode Forward Voltage | $V_{GS}=0V, I_S=-1A, T_J=25^\circ\text{C}$ | --- | --- | -1 | V |

Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed, pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
3. Essentially independent of operating temperature.

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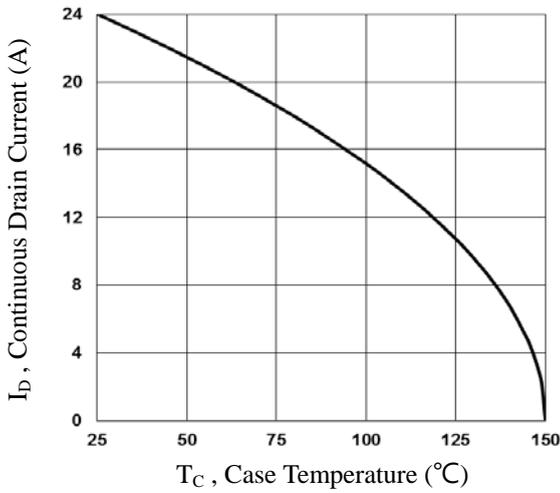


Fig.1 Continuous Drain Current vs. T_C

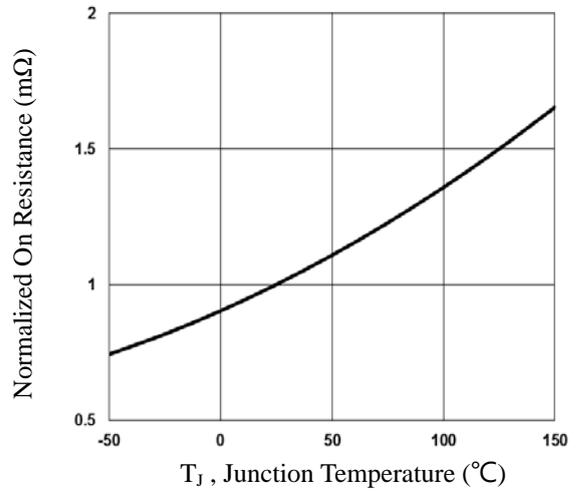


Fig.2 Normalized $R_{DS(on)}$ vs. T_J

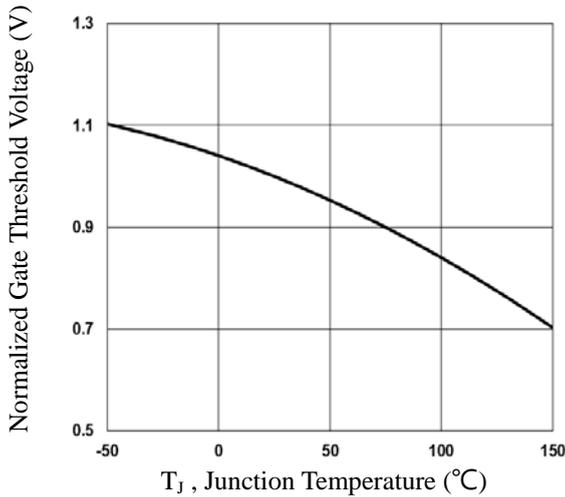


Fig.3 Normalized V_{th} vs. T_J

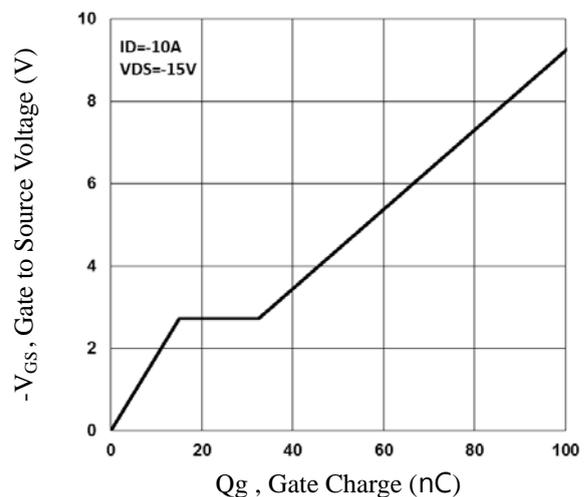


Fig.4 Gate Charge Waveform

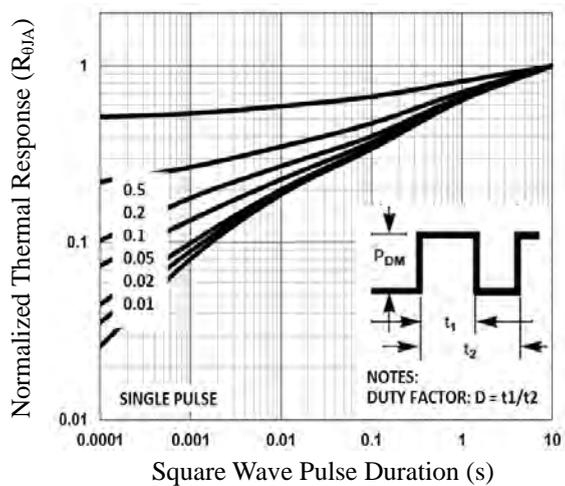


Fig.5 Normalized Transient Impedance

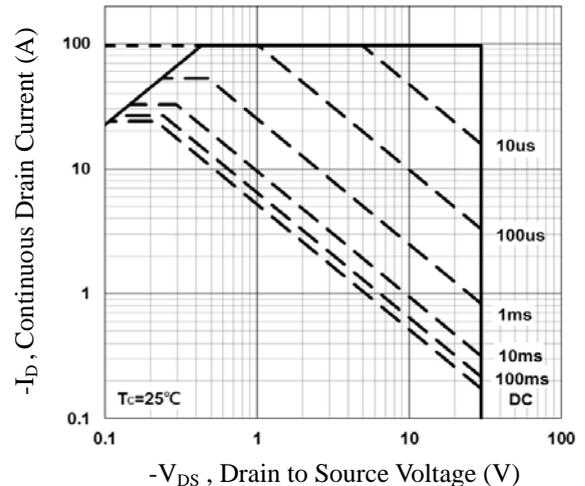


Fig.6 Maximum Safe Operation Area

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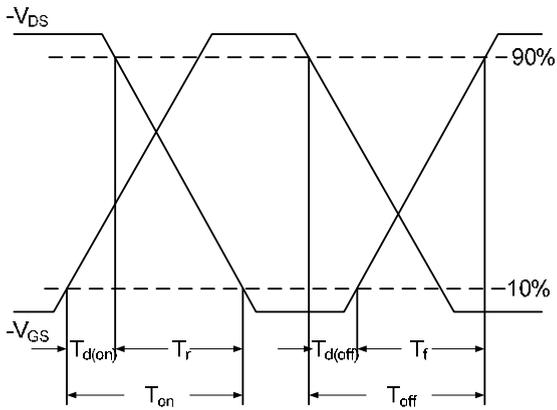


Fig.7 Switching Time Waveform

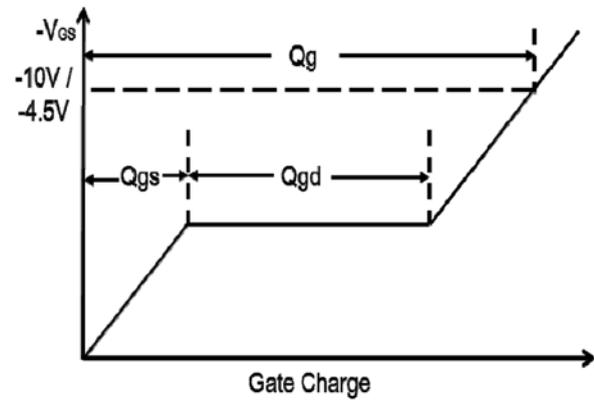
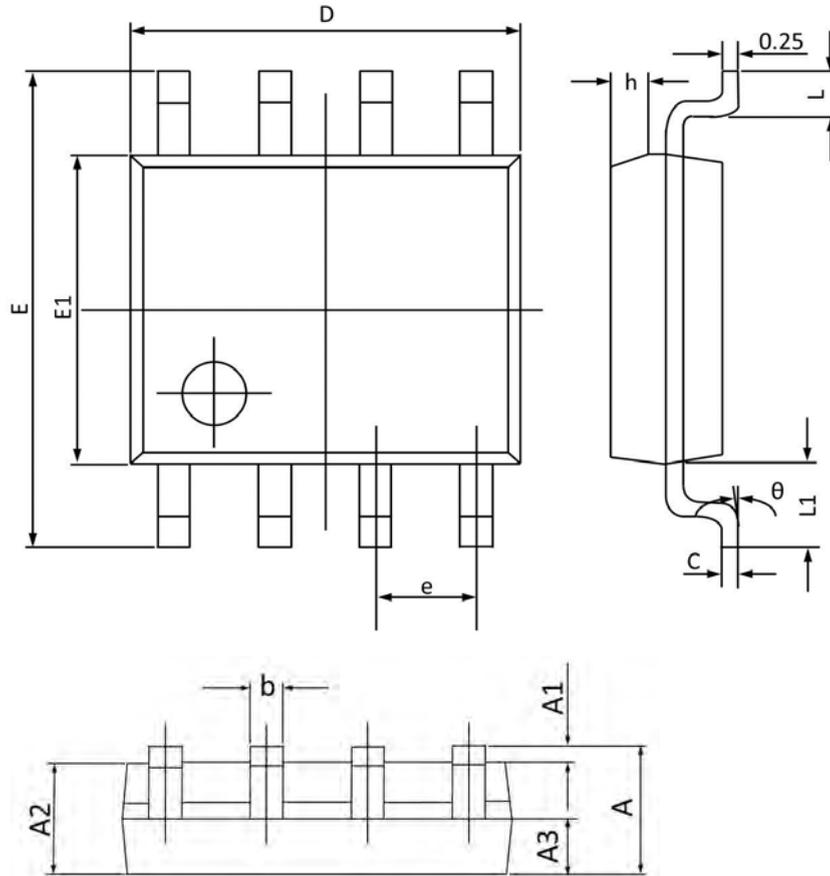


Fig.8 Gate Charge Waveform

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SOP-8 PACKAGE INFORMATION



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|----------|---------------------------|-------|----------------------|-------|
| | Min | Max | Min | Max |
| A | 1.350 | 1.750 | 0.053 | 0.068 |
| A1 | 0.100 | 0.250 | 0.004 | 0.009 |
| A2 | 1.300 | 1.500 | 0.052 | 0.059 |
| A3 | 0.600 | 0.700 | 0.024 | 0.027 |
| b | 0.390 | 0.480 | 0.016 | 0.018 |
| c | 0.210 | 0.260 | 0.009 | 0.010 |
| D | 4.700 | 5.100 | 0.186 | 0.200 |
| E | 5.800 | 6.200 | 0.229 | 0.244 |
| E1 | 3.700 | 4.100 | 0.146 | 0.161 |
| e | 1.270(BSC) | | 0.050(BSC) | |
| h | 0.250 | 0.500 | 0.010 | 0.019 |
| L | 0.500 | 0.800 | 0.019 | 0.031 |
| L1 | 1.050(BSC) | | 0.041(BSC) | |
| θ | 0° | 8° | 0° | 8° |